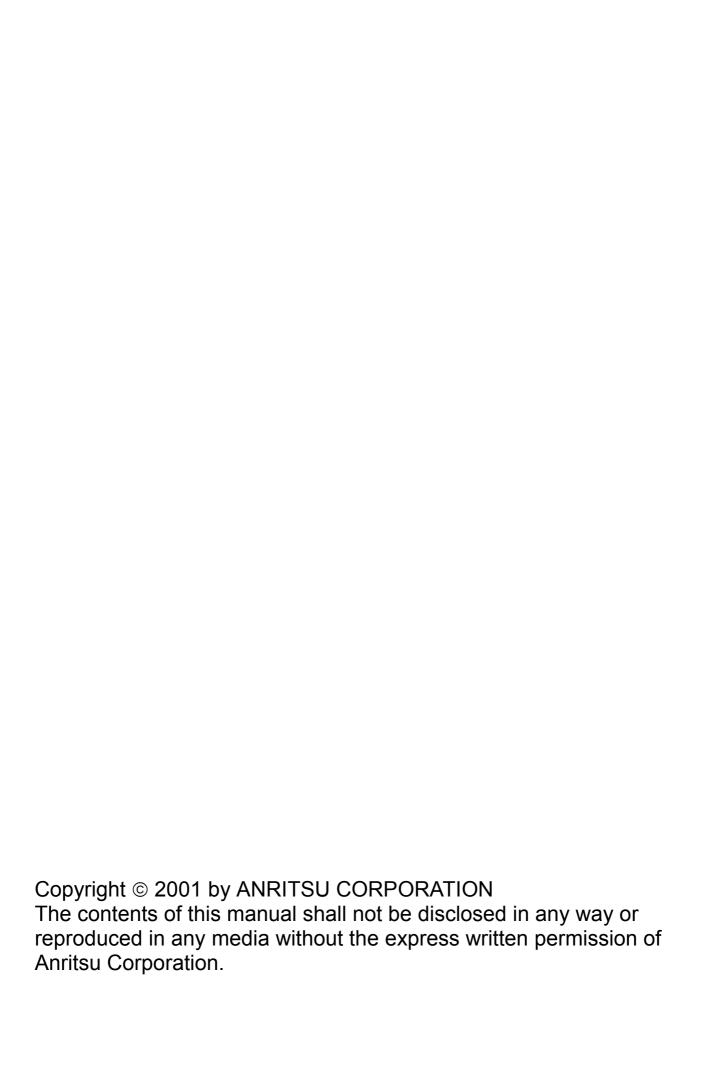


PRODUCT INTRODUCTION

MP1570A SONET/SDH/PDH/ATM Analyzer

MEASUREMENT SOLUTIONS

ANRITSU CORPORATION



The MP1570A has been developed mainly for evaluating and maintaining PDH/SDH transmission equipment; its single-cabinet, portable construction makes it perfect as a PDH/SDH/ATM analyzer. Although the functions and performance of the MP1552B have been upgraded in the new MP1570A, it is still compatible with the older SDH plug-in units (both optical and electrical) for excellent cost performance.



MP1570A SONET/SDH/PDH/ATM Analyzer

Anritsu Corporation
Measurement Solutions

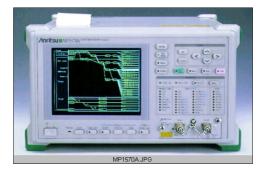
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1570-1

External View of MP1570A





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This shows the features of the MP1570A.

Features



- Plug-in Unit Method
- Supports SDH/SONET & PDH Tests
- Simple Operation
- Software Upgrade
- Built-in Printer and FDD
- Plug-in Construction
- Useful Features
- Other Functions

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1570-3

The MP1570A configuration can be selected from a full lineup of functions plus three new types of optical interface unit.

It is an extremely cost effective measuring instrument because it can also use existing MP1552B interface units.

Plug-In Unit Method



- Full Line of Interface Units
 - + Optical 1.31, 1.55, 1.31/1.55
 - Electrical NRZ, CMI
- Optical Units with Built-in Power Meter



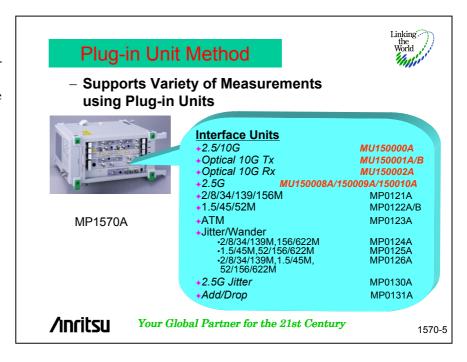
Optical 156/622M (1.31) MP0111A
Optical 156/622M (1.55) MP0112A
Optical 156/622M (1.31/1.55) MP0113A
CMI MP0105A
NRZ (156M/622M) MP0108A

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The MP1570A uses a plug-in method providing customers with flexible configuration options for various applications.

The units in red italics shown above are new units (for 2.5G).



Not only can the MP1570A plug-in units be changed, but one instrument covers a wide range including SDH/SONET mapping and PDH. Of course, both out-of-service and in-service measurement are possible.

Supports SDH/SONET & PDH Tests



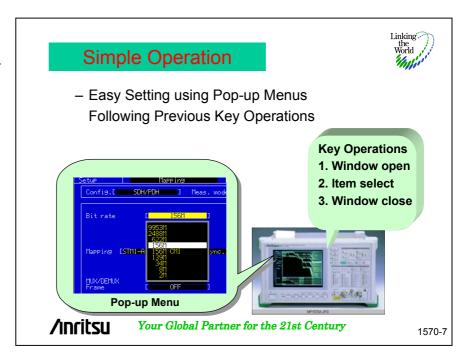
- In-service monitoring
- (G.772)

- + 2.5G,10G
- + 52M, 156M, 622M
- (G.703, G.958)
- + 2M, 8M, 34M, 139M, 1.5M, 45M(G.703)
- + SDH/SONET ← → PDH Measurement

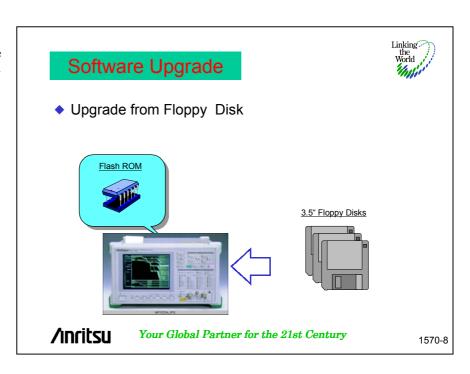
/inritsu

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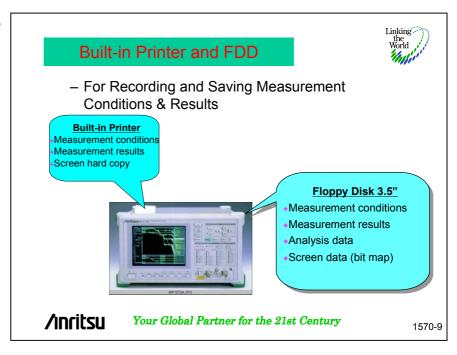
The popular key functions of the MP1552B have been inherited in the MP1570A pop-up menus for easy operability and to save time on operation training.



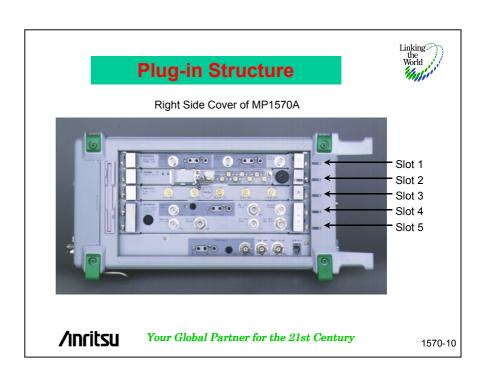
The firmware can be upgraded easily using a floppy disk when upgrading the system hardware or when ITU-T specifications change, etc.



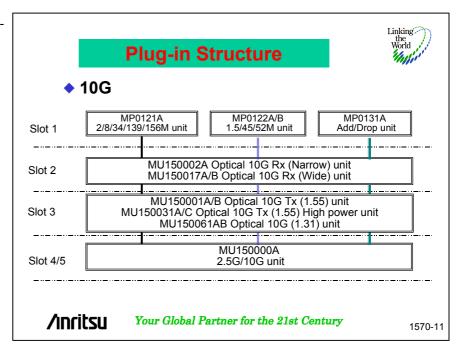
The MP1570A has a built-in printer (top edge) and floppy disk drive (right side) as standard equipment so measurement settings, results and analysis data can be either printed out directly or saved to disk and used for later analysis on a MP1570A or a PC (using graphing / spreadsheet software, etc.).



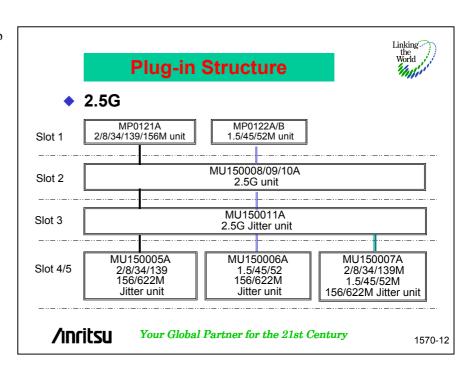
This is a side view of the MP1570A (with 2.5G Add/Drop unit installed).



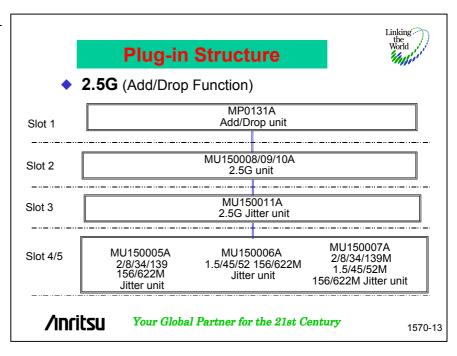
This table shows the units that can be installed for running the Add/Drop function.



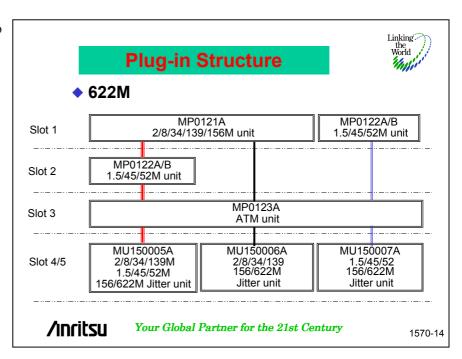
This table shows the units supported up to STM-16 (2488 Mb/s) classified by system and application.



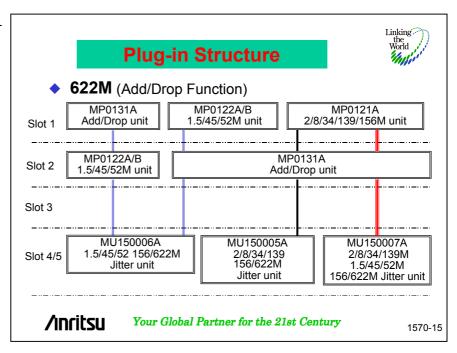
This table shows the units that can be installed for running the Add/Drop function.



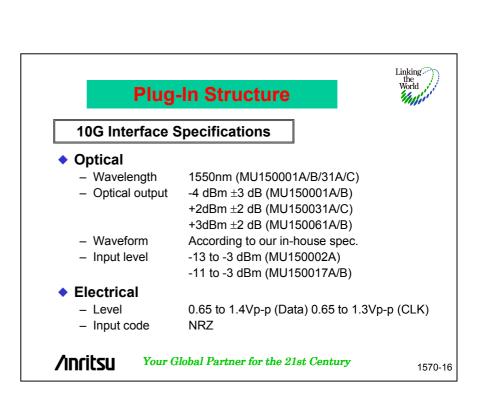
This table shows the units supporting up to STM-4 (622 Mb/s) classified by system and application.



This table shows the units that can be installed for running the Add/Drop function.



These are the specifications for the STM-64(10G) optical unit.



These are the specifications for the STM-16(2.5 G) optical unit.

Plug-in Structure



2.5G Interface Specifications

Optical

– Wavelength1310, 1550, 1310/1550 nm

(MU150008A/150009A/150010A)

Electrical

Level ECL (send/receive)Monitor input NRZ (clock recovery)

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1570-17

This table shows the functional features of the MP1570A.

Functional Features

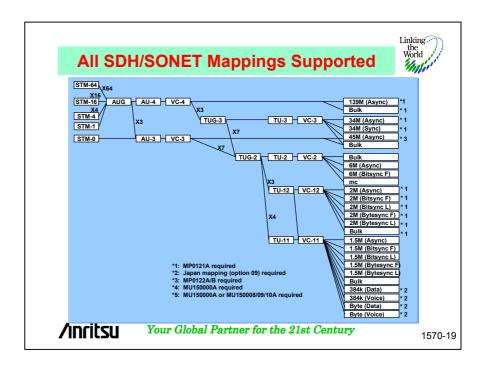


- All SDH/SONET Mappings Supported
- Concatenation Mapping
- SONET/ITU-T Compliance Tests
- Full Through Mode Functions
- Error Performance Analysis
- Automatic Trouble Search
- SDH/SONET Pointer Generation
- PDH MUX/DEMUX Function (Option)
- ◆ Jitter/Wander Generation/Measurement at all Bit Rates
- ATM Pattern Generation/Measurement
- Auto-setup

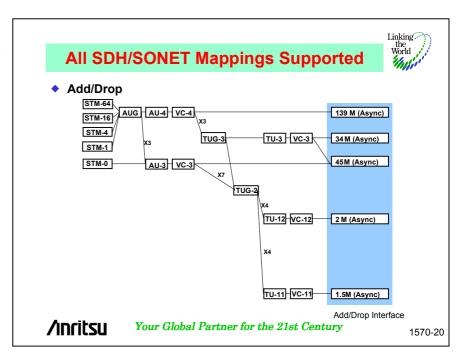
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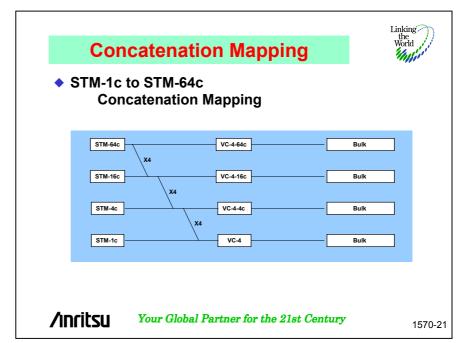
This shows the mapping of the MP1570A.

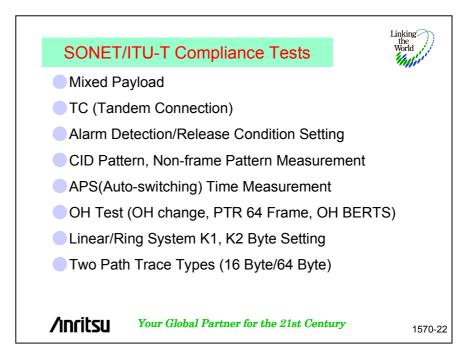


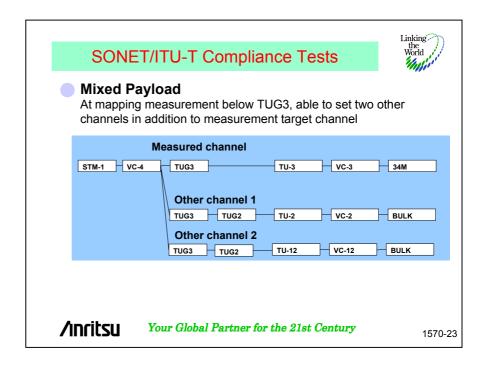
By installing an Add/Drop unit, a PDH signal can either be added to or dropped from an SDH signal.



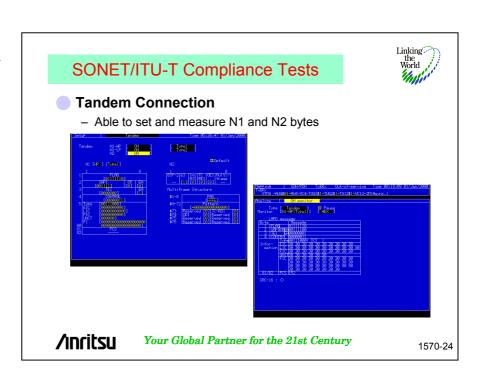
This shows the concatenation mapping of the MP1570A.



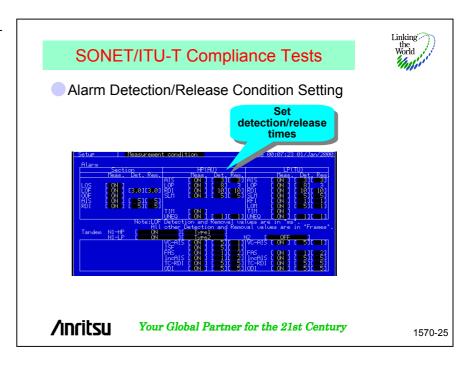




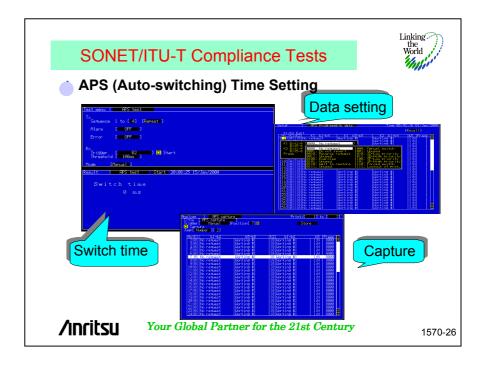
POH N1,N2 bytes can be set. Errors/Alarms can be measured at tandem connection.



The MP1570A can change alarm detection /release condition setting (except LOS, OOF and TIM).

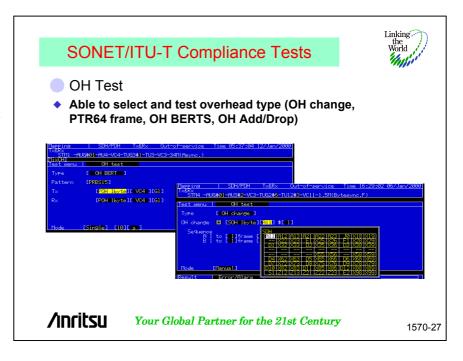


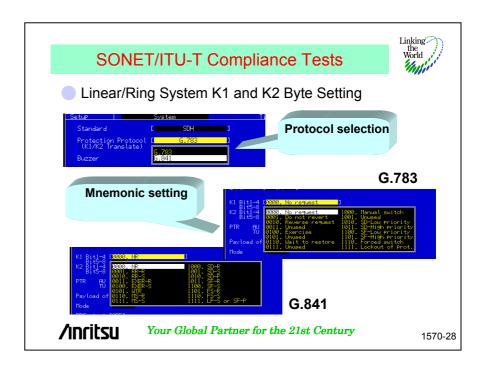
The MP1570A can edit program and capture measurement data to measure APS switching time. This measurement complies to ITU-T Rec. G.783 and G.841.



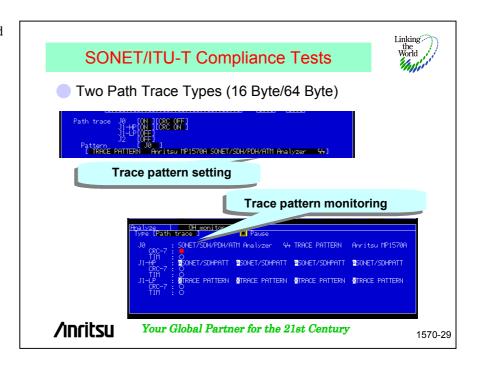
For SDH, the defaults can be set for the SOH/POH bytes except the parity and K1/K2 bytes. In addition, section and path trace can also be set.

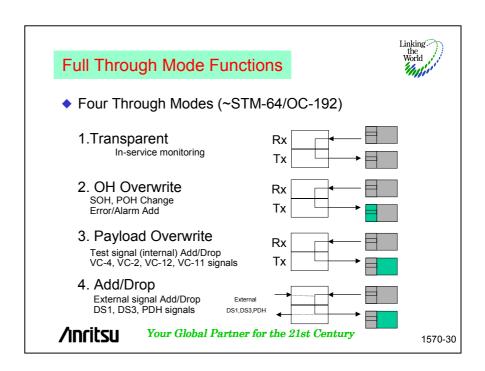
For PDH, the overhead can be set in compliance with ITU-T Rec. G.704 and G.832.





Setting/Monitoring of section trace and path trace (J0, J1 and J2) can also be possible.





Performance can be measured both inservice and out-of-service in accordance with G.821, G.826, M2100 and M2101. Moreover, measurements for G.821 analysis can be performed either in compliance or not in compliance with Annex-D.

Error Performance Analysis



- ◆ Both In-service & Out-of-service
- ◆ G.821 ANNEX-D or G.821

Туре	Error	Parameter
G.821	Bit, FAS, Code	EC, ES, EFS, SES, DM, US,
		Code ES
M.2100	Bit, FAS or CRC-4 or	ES, SES, US
	Parity or CRC-6, E-bit	
G.826	Bit, FAS or CRC-4 or	ES, SES, BBE, ESR, SESR,
	Parity or CRC-6, BIP, REI	BBER, SDP, US
M.2101	BIP, REI	ES, SES, US
M.2110	Same as M.2100, M2101	ES, SES, US (2-hour, 24-hour, 7-day)
M.2120	Same as M.2100, M2101	TR1-ES, TR1-SES, TR2-ES, TR2-SES, ES, SES, US

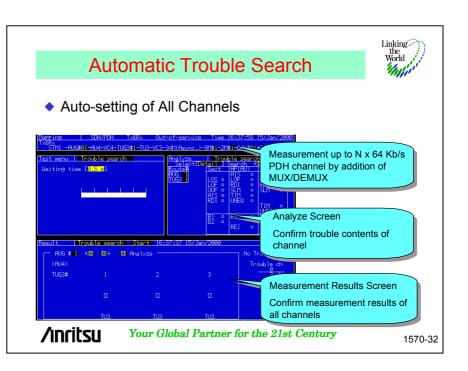
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1570-31

The trouble search function automatically measures all channels (tributaries) of input signals set at the setting screen. If an error or alarm is detected during measurement, it is displayed on the analyze screen and the channel with the trouble can be examined manually when measurement is finished.

By installing the MUX/DEMUX function (option), all channels from N x 64 K to 622M (7860 channels—CEPT system) can be measured automatically, which demonstrates its usefulness by greatly shortening the measurement period at circuit installation, etc.

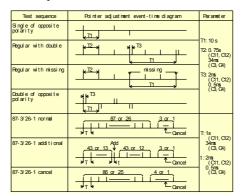


The MP1570A can perform four pointer sequence tests satisfying ITU-T G.783. Moreover, it can also perform three 87:3 pointer sequence tests to give a total of seven tests in all.

SDH/SONET Pointer Generation



- Compliance with ITU-T G.783
 - Combined jitter measurement



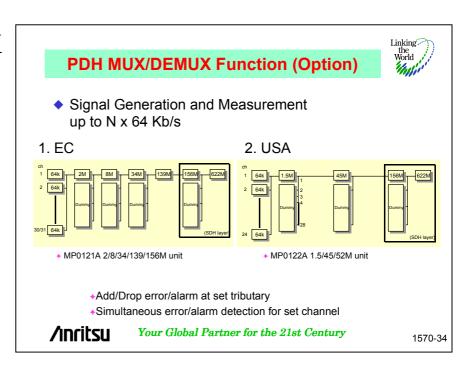
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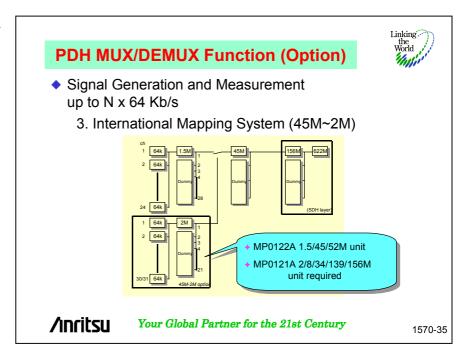
1570-33

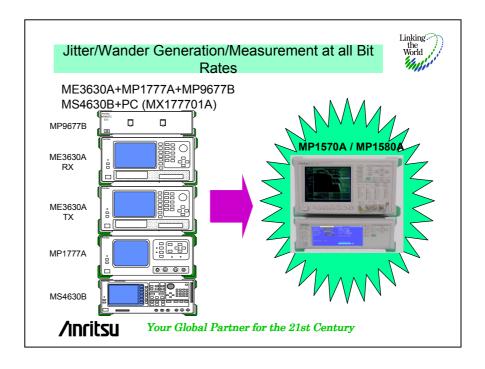
When the MUX/DEMUX function (option) is added, measurement can be performed from N x 64K to SDH for each of the Japanese, European and N. American systems.

Moreover, error/alarm addition can be performed for the selected tributary for evaluation testing of transmission equipment.



The same testing is also possible for international mappings.





These are the jitter specifications for STM-16 (2.5G).

Jitter/Wander Generation/Measurement at all Bit Rates



MU150011A 2.5G Jitter Unit

Jitter Generation

Modulation frequencyAmplitude0.1 Hz~20 MHz0 to 808 Ulp-p

Jitter tolerance ITU-T G.825,G.958 A,G.958 B, User

- Offset \pm 70.0 ppm/0.1 ppm

Jitter Measurement

/incitsu

Units
 UI p-p, UI+p, UI-p/UI rms (opt-01)
 Measurement range
 2UI 0.000 to 2.020 UIp-p

32UI 0.00 to 32.20 Ulp-p

- Ref. signal Internal/External

- Jitter transfer char. ITU-T G.958 A,G.958 B, User

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1570-37

These are the STM-16 (2.5G) wander specifications.

Jitter/Wander Generation/Measurement at all Bit Rates



MU150011A 2.5G Jitter Unit

Wander Generation

– Frequency 10 μHz~0.2 Hz

Amplitude 0 to 57600 Ulp-p/10 step

Ulp-p

Wander Measurement

Same as MU150005A/MU150006A/MU150007A option 02

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Wander measurement (option) can be performed by adding the relevant option. Measurement can be performed at all bit rates of 1.5M, 2M, 8M, 34M, 45M,139M, 52M, 156M, 622M and 2488M.

There are four measurement units: Peak-to-Peak, +Peak, -Peak and TIE.

Jitter/Wander Generation/Measurement at all Bit Rates



- ◆ Wander Measurement (option) (Rec. 0.172)
 - Measurement UnitsPeak-to-Peak, +Peak/-Peak, TIEResolution 0.5 ns
 - Filter
 DC to 0.01 Hz, DC to 10 Hz, 0.01 to 10 Hz
 - Reference Clock2 Mb/s (HDB3), 2 MHz,1.5 Mb/s (AMI/B8ZS), 1.5 MHz
 - MTIE/TDEV MX150001B Software (host PC)

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1570-39

Frequency offset and measurement can be performed by installing a jitter generation/measurement module.

Frequency offset can be measured at either jitter ON or jitter OFF.

The frequency of the signal input from the connector is measured with a resolution of 0.1 ppm in units of either ppm or Hz.

Jitter/Wander Generation/Measurement at all Bit Rates



Frequency Offset

Frequency Offset at Jitter Generation

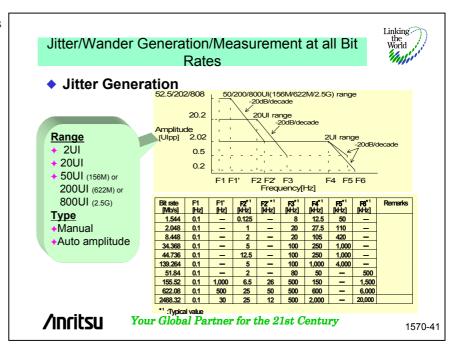
- Two offset ranges
 - \pm 999.9 ppm/0.1 step (jitter off)
 - \pm 70.0 ppm/0.1 step (jitter on)
- Accuracy 0.1 ppm
- Frequency Measurement
 - Resolution 0.1ppmDisplay Hz or ppm

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The MP1570A can generate jitter signals that comply with the ITU-T O.171 recommendation. Any of five jitter amplitude ranges can be selected: 2, 20, 50, 200 and 800 UIp-p.

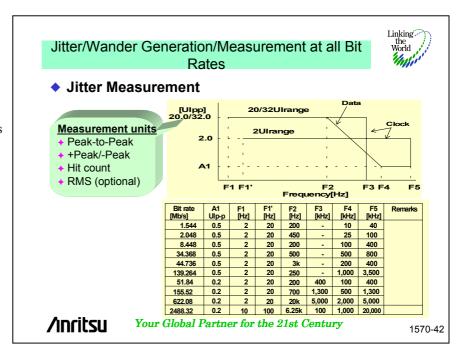
The jitter frequency covers a wide range from 0.1 Hz~20 MHz.



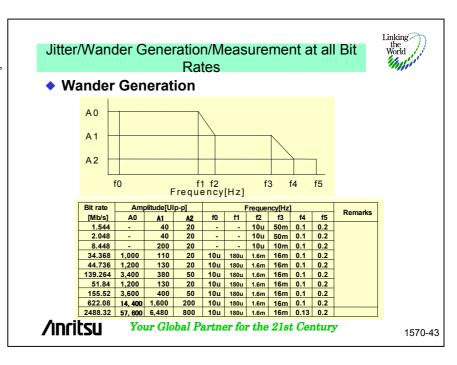
Jitter can also be measured in compliance with ITU-T O.171.

The jitter amplitude can be measured in two ranges; the maximum range is 20 (~622M)/32 UIp-p (2488M)

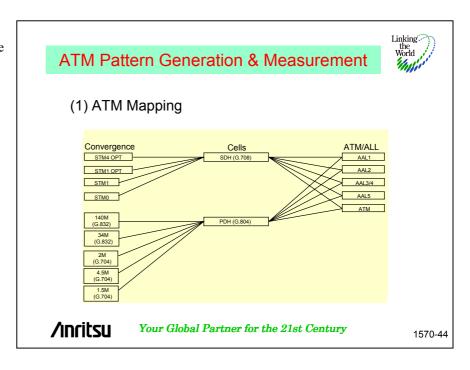
The jitter measurement frequency is 2 Hz~20 MHz, and the measurement units can be selected from Peak-to-Peak, +Peak/-Peak, RMS (option) and Hit Count.



By adding a jitter generation/measurement module, not only can a jitter signal be generated and measured, but a wander signal (option) can also be generated too in compliance with the ITU-T O.171 recommendations like the jitter signal.



Installing the MP0123A ATM unit permits generation and measurement of the following ATM signals: 2, 34, 139, 156M (with MP0121A 2/8/34/139/156M unit), 1.5, 45, 52M (with MP0122A 1.5/45/52M unit) and 156, 622M (with MP0111A/0112A/0113A Optical unit).



Various types such as CBR and burst can be used as the traffic pattern at cell sending and three types of setting method: cell/s, Kb/s and %, can be used. When burst or sawtooth is selected, the setting conditions are easy-to-understand because the send method is displayed on the screen.

In addition, 10 patterns can be edited as the background cell.

Each can be sent in the range of 0% to 100%. (The upper limit depends on the Distribution setting.)

ATM Pattern Generation & Measurement



(2) Traffic

Distribution

 Mode CBR, Burst, PCR with CDV, Poisson, Sawtooth

+Timing

Single, Continuous

Units
cell/s, Kb/s, %



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1570-45

Each type of cell data can be edited. The 65535 byte data of the AAL3/4 and AAL5 payload pattern can be edited on the screen or externally edited data can be read from floppy disk.

Edited 2016 cell data (header and payload) can be sent as memorized cells. Furthermore, the 2106 cell data received by using the receive capture function can also be sent.

ATM Pattern Generation & Measurement



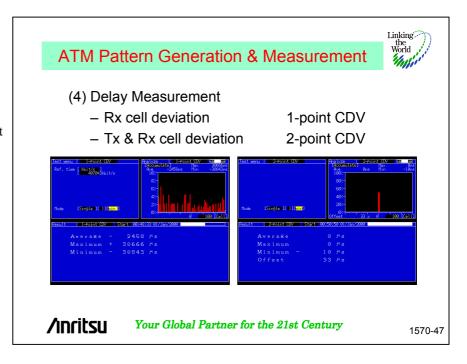
- (3) Cell Editing
 - Foreground cellO.191, AAL1,AAL2, AAL3/4, AAL5
 - OAM CellAIS, RDI, CC, loopback, PM
 - Background cell (10 ch)
 - Memorize cell
 - +1 to 2016 cell
 - Able to recall data in cell memory

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Two delay times can be measured: 1-point CDV (the variance in the receive cell arrival time) and 2-point CDV (the randomness in the time from cell sending to receiving).

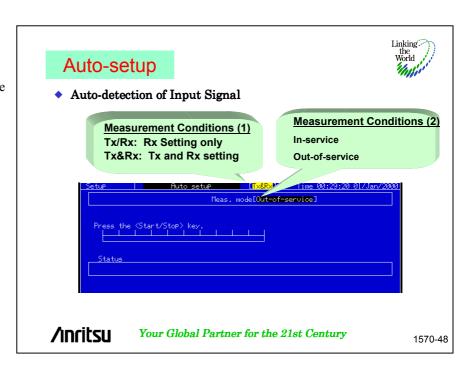
Since 1-point CDV and 2-point CDV measurements both have an independent measurement structure, measurement is very easy. In addition, the measurement results can be displayed either numerically or graphically for easy reading.



This function detects the receive signal condition and sets the MP1570A measurement conditions automatically.

It can be executed at both out-of-service and in-service; at in-service, mappings and frames can be both detected, but at out-of-service, pattern detection is also possible too.

However, this function does not detect ATM patterns.



Other Functions



- Overhead Setting
- Dummy Channel
- Signaling Preset (Option 09)
- Full Error/Alarm Generation & Measurement
- Data Capture
- Complete Monitoring Functions
- Self Test

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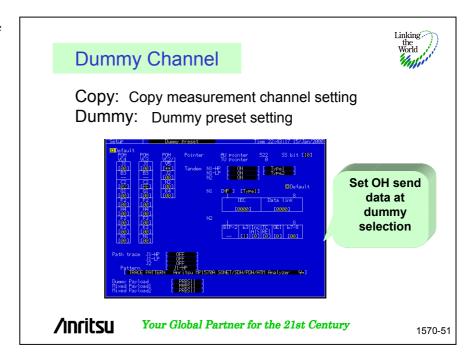
1570-49

For SDH, the defaults can be set for the SOH/POH bytes except the parity and K1/K2 bytes. In addition, section and path trace can also be set.

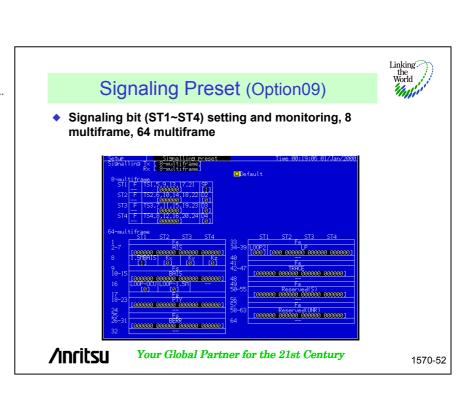
For PDH, the overhead can be set in compliance with ITU-T Rec. G.704 and G.832.

Overhead Setting OH Preset SOH SOH/POH Pattern (inc. path trace pattern) PDH E3, E4, DS3 PLCP Pattern (ATM) (inc. trail trace pattern) (inc. trail trace pattern) Vour Global Partner for the 21st Century

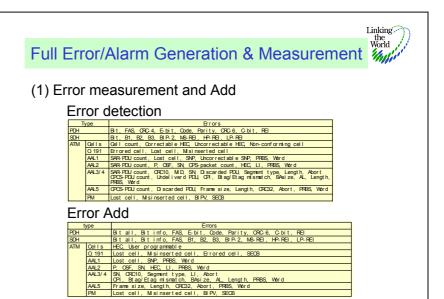
The MP1570A can copy and preset the measurement channel data to the dummy channel.



Setting or monitoring the signaling bit (ST1~ST4) can be performed by installing option 09 in the MP1570A.



This shows the error measurement and addition items.



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1570-53

This shows the alarm measurement and addition items.

For ATM, AIS, RDI and continuity check cells supporting F4 and F5 can be added and measured for OAM testing.

Full Error/Alarm Generation & Measurement



(2) Alarm measurement and Add Alarm detection

Type	Al arms
PDH	LOS, ALS, LOF, MF Loss, RDI, RDI(MF), Sync Loss
SDH	LCS, LCF, COF, MS-ALS, MS-RDL, AU-ALS, AU-LCP, HP-RDL, HP-SLM, TU-ALS, TU-LCP, LP-RDL, LP-RFL, LP-SLM, Sync Loss ,HP-UNEQ,LP-UNEQ,HP-TIM,LP-TIM
ATM	LCD, VP/VC segment AIS, VP/VC segment RDI, VP/VC segment LCC, VP/VC end-to-end AIS, VP/VC end-to-end RDI, VP/VC end-to-end LCC, Sync Ioss

Alarm Add

Type	Al arms
PDH	LOS, ALS, ROL, ROL(MF)
SDH	LOS, LOF, MS-ALS, MS-ROL, AU-ALS, AU-LOP, HP-ROL, TU-ALS, TU-LOM, TU-LOP, LP-ROL, LP-RFL, HP-SLM,LP-SLM,HP-UNEQ,LP-UNEQ,HP-TIM,LP-TIM
ATM	LCD, VP/VC AIS, VP/VC RDI, VP/VC CC, VP/VC Loopback cell

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Full Error/Alarm Generation & Measurement



(3) Tandem Connection Errors/Alarms Alarms

VC-AIS, ISF, FAS, HP-Incoming AIS, HP-TC-RDI, HP-ODI, LP-Incoming AIS, LP-TC-RDI, LP-ODI

Errors

N2 BIP-2, TC-REI, OEI, HP-IEC

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1570-55

Any 1 byte of SOH or the K1/K2 bytes can be captured in 64 frames according to specified trigger conditions.

The captured data is displayed in either ASCII, hexadecimal or binary.

2016 ATM cells can be captured by specified trigger conditions and the captured cells are displayed in hexadecimal, ASCII or mnemonic.

In addition, the captured cells can be sent as memorized cells.

Data Capture



- OH Capture
 - + Type Any 1 byte of SOH/POH, H1/H2, K1/K2 + Trigger Manual, Error/Alarm, K1/K2 mismatch, K1/K2 match, NDF, +PJC, -PJC, 3 cons

→ Display ASCII/HEX, Binary

- Cell Capture
 - + 1 to 2016 cells
 - + Trigger+ Display+ DisplayHEX, ASCII, Translate



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Any 1 byte of SOH or the K1/K2 bytes can be captured in 64 frames according to specified trigger conditions.

The captured data is displayed in either ASCII, hexadecimal or binary.

2016 ATM cells can be captured by specified trigger conditions and the captured cells are displayed in hexadecimal, ASCII or mnemonic.

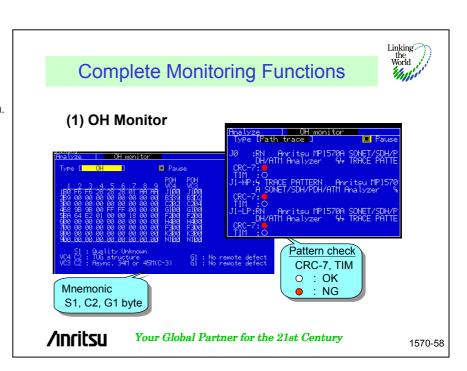
In addition, the captured cells can be

sent as memorized cells.

Data Capture - Frame capture (Option13) • Memory size 64 frames (156M, 622M, 2.5G), 26 frames (10G) • Trigger Manual, Error, Alarm, K1/K2 mismatch, K1/K2 match, NDF, +PJC, -PJC, 3 cons, External • Display HEX, ASCII

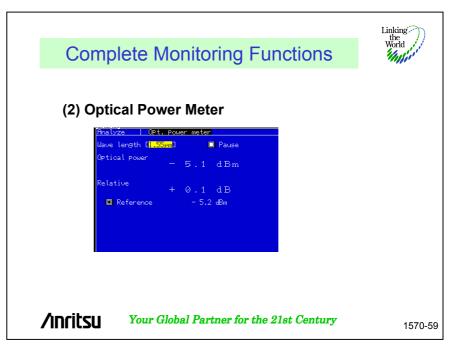
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In comparison to the MP1552B, more powerful functions have been added, such as an S1 and C2 byte mnemonic display, TIM alarm detection at path trace, and a display update stop function.

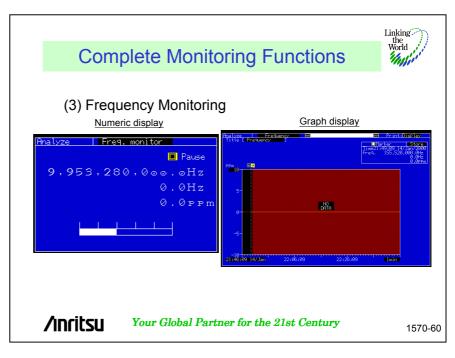


/incitsu

Optical power can be measured easily by installing the current MP0111A/MP0112A/MP0113A, new MU150008A/MU150009A/MU150010 A 2.5G Optical units and MU150002A 10G Optical unit, etc. They have a measurement range of 0 to -30 dBm (~622M), -9 to -30 dBm (2.5G) and 0 to -16 dBm (10G) at 0.1-dB resolution, and the measurement results can be displayed as either relative or absolute values.

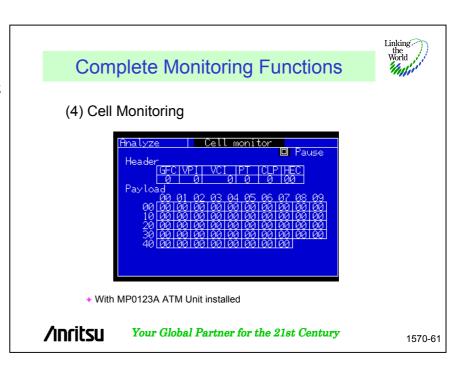


The input signal frequency can be measured. The resolution has a measurement range of $0.1 \text{ppm} \pm 1000 \text{ ppm}$ and the measurement results can be displayed as either Hz or ppm. In addition, the frequency synchronized to error/alarm measurement can be displayed as a graph, which is useful for monitoring long-term frequency deviation.

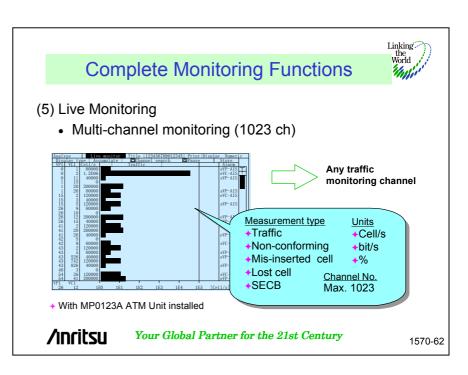


Receive cells can be monitored by installing the MP0123A ATM unit.

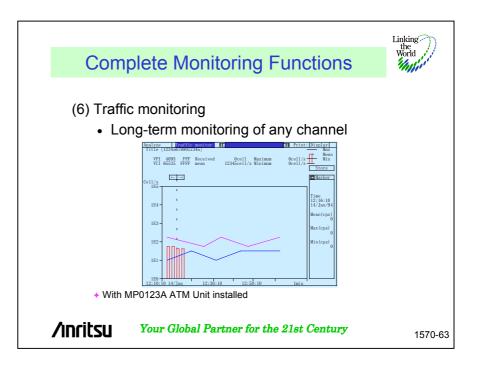
The 53 byte cell data header can be displayed as either hexadecimal or decimal; the payload is displayed in hexadecimal.



By installing the MP0123A ATM unit, 1023 channels of an in-service circuit can be auto-detected and the conditions displayed as a graph. The contents are cell traffic, UPC non-conforming cells, misinserted cells, and SECB. The circuit usage conditions can be obtained easily in this manner.

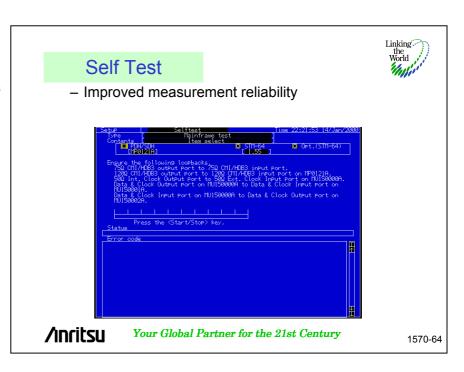


The long-term changes in an in-service channel can be displayed by installing the MP0123A ATM Unit, making it simple to monitor the conditions of a specific channel.



The MP1570A has a self-test function for checking that it is operating correctly.

If there is no fault, PASS is displayed on the screen after the test is completed. If a fault is found by the self test, FAIL is displayed and an error code is displayed at the bottom of the screen. The details of each error code are explained in the appendix of the operation manual.





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